# **Power MOSFET**

# -30 V, -4.7 A, Single P-Channel, TSOP-6

#### **Features**

- Leading -30 V Trench Process for Low R<sub>DS(on)</sub>
- Low Profile Package Suitable for Portable Applications
- Surface Mount TSOP-6 Package Saves Board Space
- Improved Efficiency for Battery Applications
- NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- Pb-Free Package is Available

#### **Applications**

- Battery Management and Switching
- Load Switching
- Battery Protection

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit		
Drain-to-Source Voltage	$V_{DSS}$	-30	V		
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain Cur-	Steady	T <sub>A</sub> = 25°C	$I_D$	-3.7	Α
rent (Note 1)	State	T <sub>A</sub> = 85°C		-2.7	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-4.7	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.25	W
	t ≤ 5 s			2.0	
Continuous Drain Cur-	$ \begin{array}{c c} \text{Steady} & T_{\text{A}} = 25^{\circ}\text{C} \\ \text{State} & T_{\text{A}} = 85^{\circ}\text{C} \\ \end{array} $		$I_D$	-2.6	Α
rent (Note 2)				-1.9	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.63	W
Pulsed Drain Current tp = 10 μs			$I_{DM}$	-15	Α
Operating Junction and Sto	T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C		
Source Current (Body Dioc	Is	-1.7	Α		
Lead Temperature for Sold (1/8" from case for 10 s)	T <sub>L</sub>	260	°C		

#### THERMAL RESISTANCE RATINGS

Rating	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	100	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 1)	$R_{\theta JA}$	62.5	
Junction-to-Ambient - Steady State (Note 2)	Reja	200	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.006 in sq).

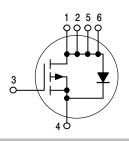


## ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
-30 V	38 mΩ @ –10 V	-4.7 A
	68 mΩ @ -4.5 V	

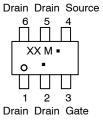
#### P-Channel



# MARKING DIAGRAM & PIN ASSIGNMENT



TSOP-6 CASE 318G STYLE 1



XX = Specific Device Code M = Date Code\*

= Pb-Free Package
 (Note: Microdot may be in either location)

\*Date Code orientation may vary depending upon manufacturing location.

#### ORDERING INFORMATION

See detailed ordering and shipping information ion page 5 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25$ °C unless otherwise noted)

Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				-17		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -24 V	$T_J = 25^{\circ}C$			-1.0	μΑ
		$V_{DS} = -24 \text{ V}$	T <sub>J</sub> = 125°C			-100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{E}$	<sub>O</sub> = -250 μA	-1.0		-3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V},$	$I_D = -3.7 \text{ A}$		38	60	mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -2.7 \text{ A}$			68	110	
Forward Transconductance	9FS	$V_{DS} = -10 \text{ V},$	$I_D = -3.7 \text{ A}$		6.0		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>				750		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, } f = 1.0 \text{ MHz,}$ $V_{DS} = -15 \text{ V}$			140		
Reverse Transfer Capacitance	C <sub>RSS</sub>				105		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -10 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = -3.7 \text{ A}$			15.25	32	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.8		1
Gate-to-Source Charge	Q <sub>GS</sub>				2.6		
Gate-to-Drain Charge	$Q_{GD}$				3.4		
SWITCHING CHARACTERISTICS, VGS = -1	<b>0 V</b> (Note 4)						
Turn-On Delay Time	t <sub>d(ON)</sub>				9.0	17	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -10 V, \	/ <sub>DD</sub> = -15 V,		9.0	18	7
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = -10 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = -1.0 \text{ A}, R_{G} = 6.0 \Omega$			38	85	1
Fall Time	t <sub>f</sub>				22	45	1
SWITCHING CHARACTERISTICS, VGS = -4	I.5 V (Note 4)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = -1.0 \text{ A}, R_{G} = 6.0 \Omega$			11	20	ns
Rise Time	t <sub>r</sub>				15	28	
Turn-Off Delay Time	t <sub>d(OFF)</sub>				28	56	1
Fall Time	t <sub>f</sub>				22	50	1
DRAIN - SOURCE DIODE CHARACTERIST	ics	•			•	•	•
Characteristic	Symbol	Test Co	ndition	Min	Τνp	Max	Unit

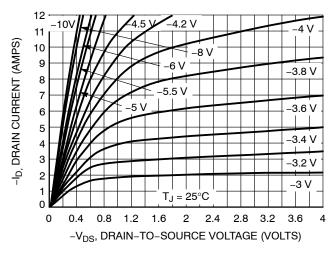
Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
Forward Diode Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		-0.76	-1.2	V
		$V_{GS} = 0 V,$ $I_{S} = -1.0 A$	T <sub>J</sub> = 125°C		-0.60		
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}$ $dI_S/dt = 100 \text{ A}/\mu \text{s}, I_S = -1.0 \text{ A}$			17	40	ns
Charge Time	t <sub>a</sub>				9.0		
Discharge Time	t <sub>b</sub>	$dI_S/dt = 100 A/\mu$	s, $I_S = -1.0 \text{ A}$		8.0		
Reverse Recovery Charge	Q <sub>RR</sub>	1			8.0		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

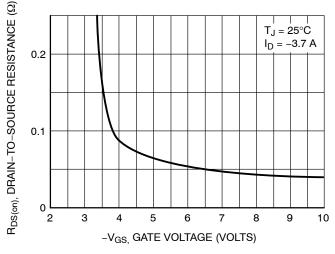
### TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



 $V_{DS} \ge -10 \text{ V}$ 11 -ID, DRAIN CURRENT (AMPS) 10 8 3 2  $T_J = -55^{\circ}C$ 1.5 2 3 3.5 4 4.5 1 -V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



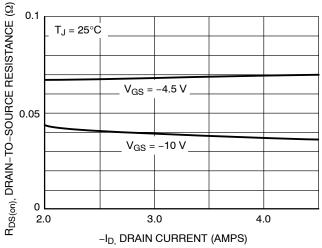
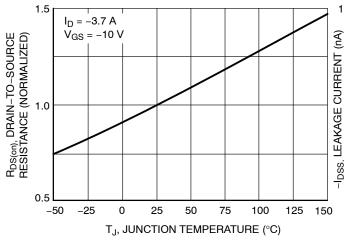


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



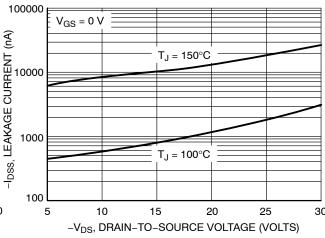
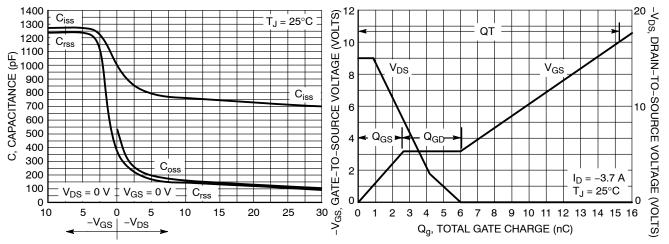


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

## TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



-GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source Voltage vs. Total **Gate Charge** 

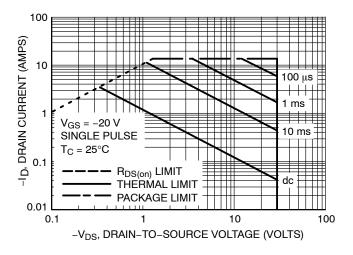


Figure 9. Maximum Rated Forward Biased Safe Operating Area

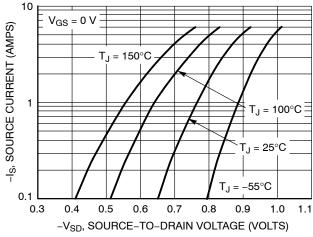


Figure 10. Diode Forward Voltage vs. Current

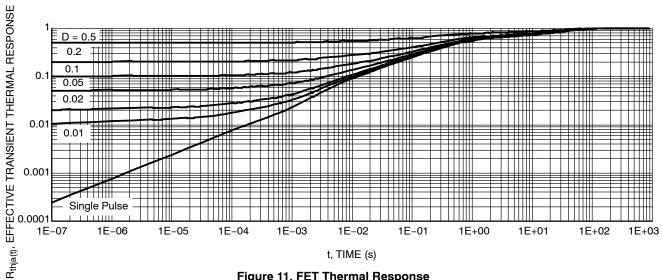


Figure 11. FET Thermal Response

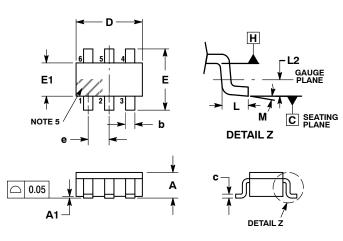
**Table 1. ORDERING INFORMATION** 

Part Number	Marking (XX)	Package	Shipping <sup>†</sup>
NTGS4111PT1	TG	SC-88	3000 / Tape & Reel
NTGS4111PT1G	TG	SC-88 (Pb-Free)	3000 / Tape & Reel
NVGS4111PT1G	VTG	SC-88 (Pb-Free)	3000 / Tape & Reel

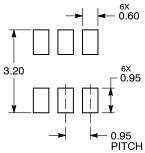
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

#### TSOP-6 CASE 318G-02 ISSUE V



#### **RECOMMENDED SOLDERING FOOTPRINT\***



**DIMENSIONS: MILLIMETERS** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
  MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM
- LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
  DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH,
  PROTRUSIONS, OR GATE BURRS, MOLD FLASH, PROTRUSIONS, OR
  GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
  5. PIN ONE INDICATOR MUST BE LOCATED IN THE INDICATED ZONE.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.01	0.06	0.10		
b	0.25	0.38	0.50		
С	0.10	0.18	0.26		
D	2.90	3.00	3.10		
E	2.50	2.75	3.00		
E1	1.30	1.50	1.70		
е	0.85	0.95	1.05		
L	0.20	0.40	0.60		
L2	0.25 BSC				
М	0°	_	10°		

#### STYLE 1:

PIN 1. DRAIN 2. DRAIN 3. GATE

- 4. SOURCE DRAIN
- DRAIN

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